Application No.: 09/957,004 Express Mail No. EV 463 363 577 US Filed: September 19, 2001 Attorney Docket No.: IMM135

**PATENT** 

## AMENDMENTS TO THE CLAIMS

1. (Previously Presented) A switch matrix circuit comprising:

a plurality of switches organized in a row and column configuration; and

a current sensing circuit coupled to the plurality of switches, the current

sensing circuit including a transistor per column of the plurality of switches, and a plurality of

resistors each electrically coupled in series with an associated one of the plurality of switches,

wherein current amplified by the transistor in a column is sensed as a logic state indicative of a

switch status of a switch within the column for a selected row, and wherein the column is

configured to conduct at least a threshold current level required for the transistor to perform the

amplification if the switch is closed, and to conduct less than the threshold current level if the

switch is open, regardless of how many other of the plurality of switches are closed.

2. (Original) The switch matrix circuit of claim 1, wherein the transistor further comprises a

bipolar junction transistor.

3. (Original) The switch matrix circuit of claim 1, wherein the row and column configuration

further comprises an off-diagonal configuration having one switch per row and column

intersection in all but one intersection per row.

4. (Original) The switch matrix circuit of claim 3, wherein each intersection lacking a switch

lies in a different column within each row.

Filed: September 19, 2001 Attorney Docket No.: IMM135

**PATENT** 

5. (Original) The switch matrix circuit of claim 4, wherein a single scan line supports providing

a row input signal or reading a column output signal for one row and one column within the off-

diagonal configuration.

6. (Original) The switch matrix circuit of claim 1, wherein a processor senses the switch status.

7. (Previously Presented) A circuit for more efficient switch selection sensing, the circuit

comprising:

a switch matrix comprising a plurality of switches organized as a plurality of rows and

columns;

a current sensing circuit coupled to the switch matrix; and

a processor coupled to the switch matrix and the current sensing circuit by a plurality of

scan lines, wherein selection of a single row by a scan line returns column current levels from the

current sensing circuit to detect if a switch at an intersection of the single row and a column of

the switch matrix is closed, and wherein a column current level associated with the column is at

least a threshold current level required for detection if the switch is closed, and the column

current level associated with the column is less than the threshold current level if the switch is

open, regardless of how many other of the plurality of switches are closed.

Filed: September 19, 2001 Attorney Docket No.: IMM135
PATENT

8. (Original) The circuit of claim 7, wherein the plurality of scan lines further comprise a

plurality of bi-directional scan lines wherein a single scan line provides both row selection and

column sensing capabilities.

9. (Original) The circuit of claim 8, wherein the organization of the plurality of switches further

comprise an off-diagonal organization to support the bi-directional scan lines.

10. (Previously Presented) The circuit of claim 7, wherein the current sensing circuit further

comprises a circuit comprising a plurality of transistors each coupled to an associated column,

and a plurality of resistors each coupled in series with an associated one of the plurality of

switches in the switch matrix.

11. (Previously Presented) The circuit of claim 10, wherein the column current level associated

with the column is at least the threshold current level when the transistor coupled to the column

is turned on.

12. (Original) The circuit of claim 10, wherein the transistor further comprises a bipolar

junction transistor.

13. (Previously Presented) A method for sensing switch statuses, the method comprising:

coupling a current sensing circuit to a switch matrix having a plurality of switches in a

row and column configuration comprising one switch per row and column intersection; and

Filed: September 19, 2001 Attorney Docket No.: IMM135

**PATENT** 

detecting a switch status of a switch within the switch matrix based on whether a current

signal in the current sensing circuit comprises at least a threshold current level, regardless of how

many other of the plurality of switches are closed.

14. (Previously Presented) The method of claim 13, further comprising forming the current

sensing circuit comprising a transistor per column of the plurality of switches, and a plurality of

resistors each electrically coupled in series with an associated one of the plurality of switches.

15. (Previously Presented) The method of claim 14, wherein detecting the switch status of the

switch further comprises detecting current amplified by the transistor in a column as a logic state

indicative of the switch status of the switch, wherein the switch is located at an intersection of

the column and a selected row.

16. (Previously Presented) The method of claim 13, wherein detecting the switch status of the

switch further comprises utilizing a plurality of bi-directional scan lines, wherein a single scan

line provides both row selection and column sensing capabilities.

17. (Previously Presented) The method of claim 16, wherein the plurality of switches comprises

an off-diagonal organization to support the bi-directional scan lines.

18. (Previously Presented) The method of claim 14, wherein the transistor per column of the

plurality of switches comprises a bipolar junction transistor.

Application No.: 09/957,004 Express Mail No. EV 463 363 577 US Filed: September 19, 2001 Attorney Docket No.: IMM135

**PATENT** 

19. (Previously Presented) A switch matrix circuit comprising:

a plurality of switches organized in a row and column off-diagonal configuration having

one switch per row and column intersection in all but one intersection per row; and

a plurality of bi-directional scan lines, wherein a single bi-directional scan line provides

both row selection and column sensing capabilities for switch status identification, wherein:

a first bi-directional scan line of the plurality of bi-directional scan lines is

configured to conduct a first signal associated with a first logic state to a selected row of the

switch matrix coupled thereto;

a second bi-directional scan line of the plurality of bi-directional scan lines is

configured to be scanned for an output signal comprising at least a threshold level, wherein the

output signal comprises at least the threshold level only if a scanned switch at an intersection of

the selected row and a scanned column of the switch matrix is selected, wherein the scanned

column is coupled to the second scan line; and

each of the other bi-directional scan lines of the plurality of bi-directional scan

lines is configured to conduct a second signal associated with a second logic state opposite the

first logic state.

20. (Original) The switch matrix of claim 19, wherein the one intersection per row lacking a

switch lies in a different column within each row.

Filed: September 19, 2001 Attorney Docket No.: IMM135

**PATENT** 

21. (Previously Presented) The switch matrix of claim 19, wherein an analog to digital

converter senses a switch status for the scanned switch, wherein a closed switch status is sensed

if the output signal comprises at least the threshold level, and an open switch status is sensed if

the output signal comprises less than the threshold level.

22. (Original) The switch matrix of claim 19, further comprising a diode and resistor circuit for

each scan line.

Claims 23-26 (cancelled).

27. (Previously Presented) The method of claim 13, wherein detecting the switch status of the

switch comprises:

receiving a base current level associated with a low logic state in a selected row of the

switch matrix, wherein the switch is located at the intersection of the selected row and a column;

if the switch is closed, amplifying at least a portion of the base current level conducted by

the column to at least the threshold current level with a transistor coupled at its base to the

column and at its emitter to a scan line; and

scanning the scan line for the current signal, wherein the switch status is open if the

current signal is less than the threshold current level, and wherein the switch status is closed if

the current signal is at least the threshold current level.

Filed: September 19, 2001 Attorney Docket No.: IMM135
PATENT

28. (Previously Presented) The method of claim 27, wherein the selected row is a first selected

row, and further comprising:

before receiving the base current level in the first selected row, selecting the first selected

row from a selectable plurality of rows in the switch matrix;

discontinuing to receive the base current level in the first selected row;

selecting a second selected row from the plurality of selectable rows; and

receiving the base current level in the second selected row.

29. (Previously Presented) The method of claim 13, wherein the row and column configuration

comprises a first row and a second row, and wherein detecting the switch status comprises:

scanning the first row of the switch matrix; and then

scanning the second row of the switch matrix.